## nexperia

## **Quarterly Reliability Monitoring Results**

Quarters: Q1/2022 to Q4/2023

Based on structural similarity

Supplier		User Part Number					
Nexperia B.V.		PMEG3005ELS					
Name of Laboratory		Part Description					
		Nexperia DHAM	Schottky				
Assembly	reliability labs	MCD package					
Test		Test Conditions	Duration	# Lots	# Quantity	# Rejects	
	TEST						
	Pre- and Post-Stress						
# 1	Electrical Test	Tamb = 25 °C	N/A	see below	all parts	see below	
		JESD22-A113					
		Bake Tamb = 125 °C	24 hours				
	PC	Soak Tamb = 85 °C, RH = 85%	168 hours				
# 2	Preconditioning	Reflow soldering	3 cycles	212	9600	0	
		MIL-STD-750-1 M1038 Method A					
	HTRB						
	High Temperature Reverse Bias	reverse voltage <sup>[1]</sup>	10001	200		•	
# 5	Dids	Teverse voltage	1000 hours	206	9320	0	
	тс	JESD22-A104					
# 7	Temperature Cycling	-65 °C to Timax, not to exceed 150°C	500 cycles	53	2400	0	
# /	Temperature cycing		JUU Cycles	55	2400	0	
	UHAST	JESD22-A118					
# 8 <b>or</b>	Unbiased HAST	Tamb = $130 ^{\circ}\text{C}$ , RH = $85 ^{\circ}\text{M}$	— 96 hours	53	2400	0	
		JESD22-A102					
	AC	Tamb = $121 ^{\circ}C$ , RH = $100 ^{\circ}M$					
# 8a	Autoclave	Pressure = 205 kPa (29.7 psia)					
	H3TRB	JESD22-A101					
	High Humidity High	Tamb = 85 °C, RH = 85%, VR = 80 % of					
# 9	Temperature Reverse Bias	rated reverse voltage <sup>[1], [2]</sup>	1000 hours	53	2400	0	
		MIL-STD-750 Method 1037					
	IOL	ton = toff, devices powered to insure $\Delta Tj$ =					
# 10	Intermittent Operating Life	100 °C	333 hours	53	2400	0	
	RSH	JESD22-A111					
# 20	Resistance to Solder Heat	260 °C ± 5 °C	10 s	n.a.	n.a.	n.a.	
	SD Saldarahilitu	1 CTD 002					
# 21	Solderability	J-STD-002		37	1110	0	

[1] The physical limitations of Schottky diodes have to be considered (thermal runaway).

[2]The maximum applied voltage is limited by test chamber set up and does not exceed 115V.

## **Calculation of FIT and MTTF**

Test considered for FIT calculation: High Temperature Reverse Bias (HTRB, Test # 5) Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

Nexperia	
DHAM Schottky 9320 0 0,46	2,19E+09

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